

Notice of References Cited	Application/Control No. 09/967,167		Applicant(s)/Patent Under Reexamination CHU ET AL.	
	Examiner Laurie Ries		Art Unit 2176	Page 1 of 1

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NON-PATENT DOCUMENTS

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	V	"User Interface Markup Language (UIML) Draft Specification", Harmonia, Inc, Version 7, January 2000, downloaded from http://www.uiml.org/specs/docs/uiml20-17Jan00.pdf , pp. 1-64.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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